

<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09944317	PARAGIOS ET AL.
	Examiner Lavin, Christopher L	Art Unit 2624

Notes	Date	Examiner
Updated East Search	08/09/2006	CLL
Updated IEEE Search	08/08/2006	CLL
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<b>Interference Searched</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
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Class	SubClass	Date	Examiner
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